


<b>Search Notes</b> 	<b>Application/Control No.</b> 10566616	<b>Applicant(s)/Patent Under Reexamination</b> FEY ET AL.
	<b>Examiner</b> JAY M PATIDAR	<b>Art Unit</b> 2862

SEARCHED			
Class	Subclass	Date	Examiner
324	207.11-207.24,220,226,236,260-263	09/11/08	JP

SEARCH NOTES		
Search Notes	Date	Examiner
EAST searched.	09/11/08	JP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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